

MOS FIELD EFFECT TRANSISTOR 2SJ601

SWITCHING P-CHANNEL POWER MOS FET

DESCRIPTION

The 2SJ601 is P-channel MOS Field Effect Transistor designed for solenoid, motor and lamp driver.

FEATURES

• Low on-state resistance:

 $R_{DS(on)1} = 31~m\Omega~MAX.~(V_{GS} = -10~V,~I_{D} = -18~A)$ $R_{DS(on)2} = 46~m\Omega~MAX.~(V_{GS} = -4.0~V,~I_{D} = -18~A)$

- Low input capacitance:
 - $C_{iss} = 3300 \text{ pF TYP.} (V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V})$
- · Built-in gate protection diode
- TO-251/TO-252 package

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

	-		
Drain to Source Voltage (Vss = 0 V)	VDSS	-60	V
Gate to Source Voltage (VDS = 0 V)	Vgss	∓20	V
Drain Current (DC) (Tc = 25°C)	ID(DC)	∓36	Α
Drain Current (pulse) Note1	I _{D(pulse)}	∓120	Α
Total Power Dissipation (Tc = 25°C)	Pτ	65	W
Total Power Dissipation (T _A = 25°C)	Pτ	1.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	T _{stg}	-55 to +150	°C
Single Avalanche Current Note2	las	-35	Α
Single Avalanche Energy Note2	Eas	123	mJ

Notes 1. PW \leq 10 μ s, Duty cycle \leq 1%

2. Starting T_{ch} = 25°C, V_{DD} = -30 V, R_G = 25 Ω , V_{GS} = -20 \rightarrow 0 V

ORDERING INFORMATION

PART NUMBER	PACKAGE
2SJ601	TO-251
2SJ601-Z	TO-252

(TO-251)



(TO-252)



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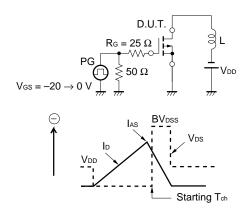
Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.



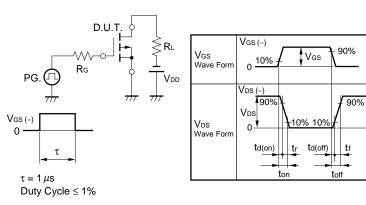
ELECTRICAL CHARACTERISTICS (TA = 25°C)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V _{DS} = -60 V, V _{GS} = 0 V			-10	μΑ
Gate Leakage Current	Igss	V _G S = ∓20 V, V _D S = 0 V			∓10	μΑ
Gate Cut-off Voltage	V _{GS(off)}	$V_{DS} = -10 \text{ V}, I_{D} = -1 \text{ mA}$	-1.5	-2.0	-2.5	V
Forward Transfer Admittance	y _{fs}	V _{DS} = -10 V, I _D = -18 A	15	30		S
Drain to Source On-state Resistance	RDS(on)1	V _G S = -10 V, I _D = -18 A		25	31	mΩ
	RDS(on)2	Vgs = -4.0 V, ID = -18 A		32	46	mΩ
Input Capacitance	Ciss	V _{DS} = -10 V		3300		pF
Output Capacitance	Coss	V _{GS} = 0 V		580		рF
Reverse Transfer Capacitance	Crss	f = 1 MHz		230		pF
Turn-on Delay Time	t d(on)	I _D = -18 A		11		ns
Rise Time	t r	V _{GS} = -10 V		12		ns
Turn-off Delay Time	td(off)	V _{DD} = -30 V		80		ns
Fall Time	t f	$R_G = 0 \Omega$		53		ns
Total Gate Charge	Q _G	V _{DD} = -48 V		63		nC
Gate to Source Charge	Qgs	V _{GS} = -10 V		10		nC
Gate to Drain Charge	Q _{GD}	ID = -36 A		16		nC
Body Diode Forward Voltage	V _{F(S-D)}	IF = 36 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 36 A, VGS = 0 V		52		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A /μs		108		nC

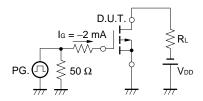
TEST CIRCUIT 1 AVALANCHE CAPABILITY



★ TEST CIRCUIT 2 SWITCHING TIME



TEST CIRCUIT 3 GATE CHARGE



140

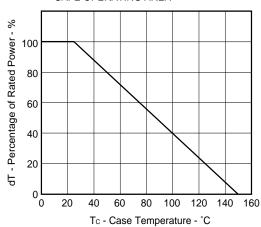
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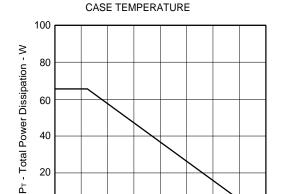
100

120

TYPICAL CHARACTERISTICS (TA = 25°C)

DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA





20

0

20

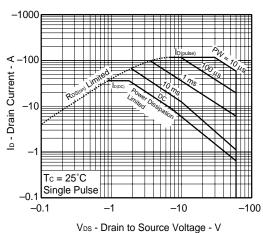
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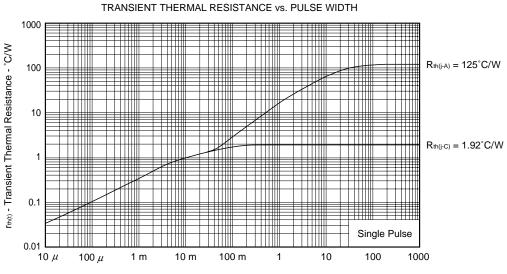
60 80

Tc - Case Temperature - °C

TOTAL POWER DISSIPATION vs.

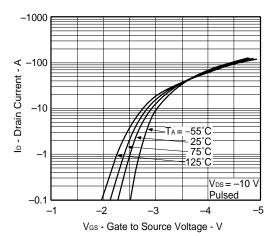
FORWARD BIAS SAFE OPERATING AREA



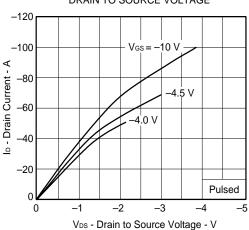


PW - Pulse Width - s

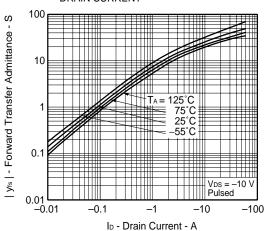
FORWARD TRANSFER CHARACTERISTICS



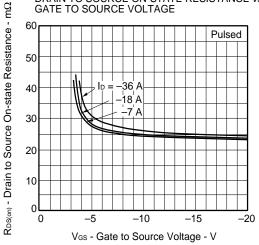
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



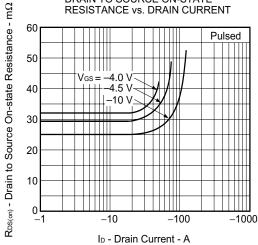
FORWARD TRANSFER ADMITTANCE vs. **DRAIN CURRENT**



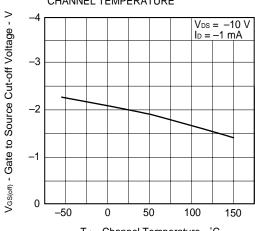
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



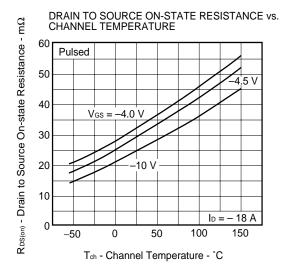
DRAIN TO SOURCE ON-STATE

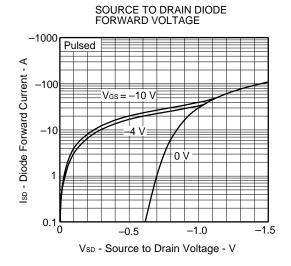


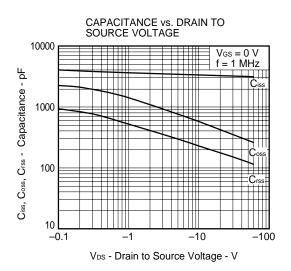
GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE

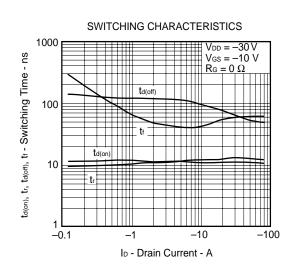


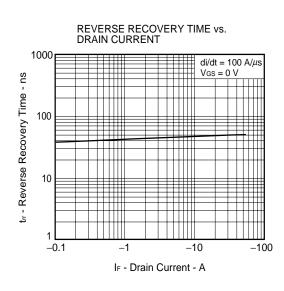
 T_{ch} - Channel Temperature - $^{\circ}C$

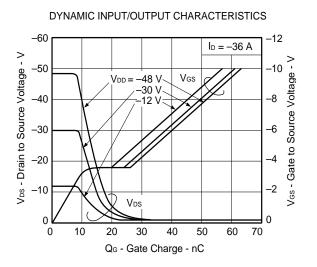


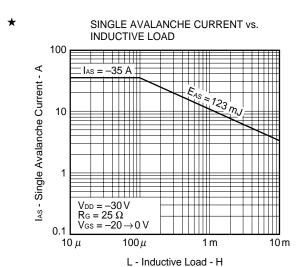


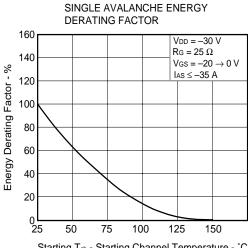








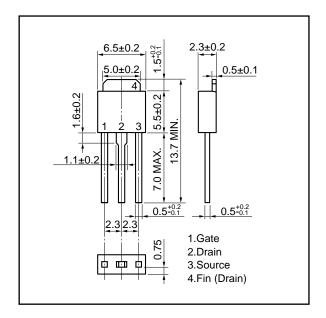




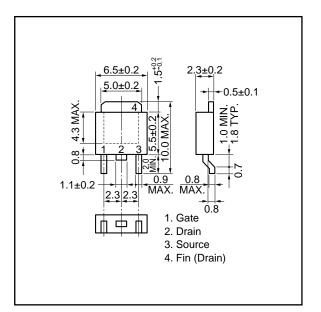


PACKAGE DRAWINGS (Unit: mm)

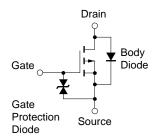
1) TO-251 (MP-3)



2) TO-252 (MP-3Z)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

Data Sheet D14646EJ3V0DS 7

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